

<b>Notice of References Cited</b>	Application/Control No. 10/742,695		Applicant(s)/Patent Under Reexamination QADEER ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Tyrrell et al. "CSP Methods for Identifying Atomic Actions in the Design of Fault Tolerant Concurrent Systems" IEEE 1995
*	V	Reps et al. "Precise Interprocedural Dataflow Analysis via Graph Reachability", 1995 ACM.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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